CD4011A, CD4012A, CD4023A Types

TEXAS INSTRUMENTS Data sheet acquired from Harris Semiconductor

CMOS NAND Gates

Quad 2 Input — CD4011A Dual 4 Input — CD4012A Triple 3 Input — CD4023A

The TI-CD4011A, CD4012A, and CD-4023A NAND gates provide the system designer with direct implementation of the NAND function and supplement the existing family of CMOS gates.

These types are supplied in 14-lead hermetic dual-in-line ceramic packages (D and F suffixes), 14-lead dual-in-line plastic packages (E suffix), 14-lead ceramic flat packages (K suffix), and in chip form (H suffix).

Features:

- Quiescent current specified to 15 V
- Maximum input leakage of 1 μA at 15 V (full package-temperature range)
- 1-V noise margin (full package-temperature range)

RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

Characteristic	Min.	Max.	Units
Supply Voltage Range (over full package temperature range)	3	12	V

MAXIMUM RATINGS, Absolute-Maximum Values:

STORAGE-TEMPERATURE RANGE (T _{Stg})
PACKAGE TYPES D, F, K, H
PACKAGE TYPE E
DC SUPPLY-VOLTAGE RANGE, (VDD)
(Voltages referenced to VSS Terminal):
POWER DISSIPATION PER PACKAGE (PD):
FOR T _A = -40 to +60°C (PACKAGE TYPE E)
FOR T _A = +60 to +85°C (PACKAGE TYPE E)Derate Linearly at 12 mW/°C to 200 mW
FOR T _A = -55 to +100°C (PACKAGE TYPES D, F, K)
FOR TA = +100 to +125°C (PACKAGE TYPES D, F, K) Derate Linearly at 12 mW/°C to 200 mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR
FOR TA = FULL PACKAGE-TEMPERATURE RANGE (ALL PACKAGE TYPES)100 mW
INPUT VOLTAGE RANGE, ALL INPUTS0.5 to VDD +0.5 V
LEAD TEMPERATURE (DURING SOLDERING):
At distance 1/16 \pm 1/32 inch (1.59 \pm 0.79 mm) from case for 10 s max

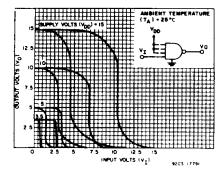


Fig. 2 — Minimum & maximum voltage transfer characteristics.

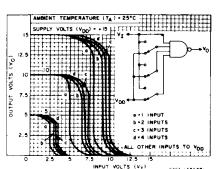


Fig. 4 — Typical multiple input switching transfer characteristics for CD4012A.

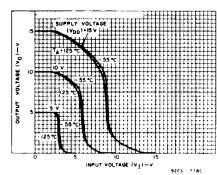


Fig. 3 — Typical voltage transfer characteristics as a function of temperature.

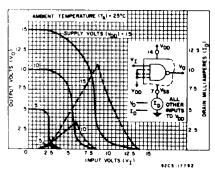
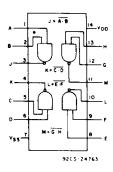
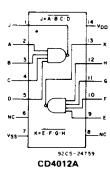


Fig. 5 — Typical current & voltage transfer characteristics.



CD4011A



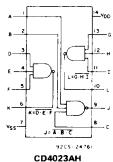
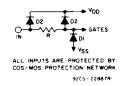


Fig. 1 - Functional diagrams.



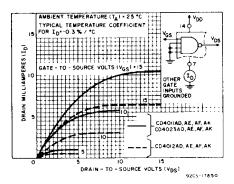


Fig. 6 - Typical n-channel drain characteristics.

CD4011A, CD4012A, CD4023A Types

STATIC ELECTRICAL CHARACTERISTICS

	Ca	nditio		Limits at Indicated Temperatures (°C)								Units
Characteristic	Conditions			D,F,K,H Packages			ges	E Package				
Characteristic	Vo	VIN	VDD	-55	+25		+125	_40	+25		+85	
	(V)	(V)	(V)		Тур.	Limit			 _	Limit		
Quiescent Device		_	5	0.05	0.001	0.05	3	0.5	0.005	0.5	15	
Current, IL Max.		_	10	0.1	0.001	0.1	6		0.005	5	30	μΑ
·	_		15	2	0.02	2	40	50	0.5	50	500	
Output Voltage: Low-Level		0,5	5		0 Typ.; 0.05 Max.							
VOL	_	0,10	10	L			Typ.; (0.05 Ma	X.			v
High Level,	_	0,5	5				1.95 Mir	<u> </u>	<u> </u>			-
Voн	_	0,10	10				9.95 Mir	1.; 10 T	yp.			
Noise Immunity: Inputs Low,	3.6	<u> </u>	5				1.5 Min.	, 2.25	Гур.			
VNL	7.2	_	10			:	3 Min.;	4.5 Typ),			V
Inputs High,	1.4	-	5	I			1,5 Min.	; 2.25	Тур.;			
VNH	2.8	-	10				3 Min.;	4.5 Typ),			
Noise Margin: Inputs Low,	4.5	_	5		1 Min.							
VNML	9	-	10		1 Min.							l v
Inputs High,	0.5	_	5				1	Min.				ľ
VNMH	1	T-	10	Ī			1	Min.				
Output Drive Current: N-Channel (Sink) IDN Min. CD4011A	0.5	_	5	0.31	0.5	0.25	0.175	0.145	0.5	0,12	0.095	
CD4023A	0.5	T_	10	0.62	0.6	0.5	0.35	0.3	0.6	0.25	0.2	Ì
	0.5	_	5	0.15	-		0.085		0.25	0.06	0.05	
CD4012A	0.5	-	10	0.31	0.6	0.25		0.155		0.13	0.105	mA
P-Channel (Source), IDP Min.	4.5	-	5	-0.31	-0.5	-0.25	-0.175	-0.145	-0.5		0.095	
All Types	9.5	_	10	-0.75	∙1.2	-0.6	-0.4	-0.35	-1.2	-0.3	-0.24	
Input Leakage Current, IL, IH		ny put	15	±10 ⁻⁵ Typ.; ±1 Max.							μΑ	

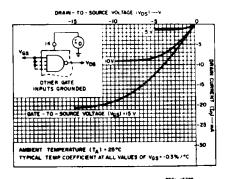


Fig. 7 — Typical p-channel drain characteristics.

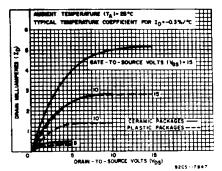


Fig. 8 — Minimum n-channel drain characteristics —CD4011A & CD4023A.

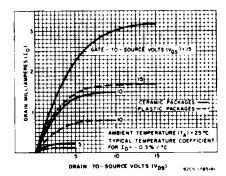


Fig. 9 — Minimum n-channel drain characteristics.

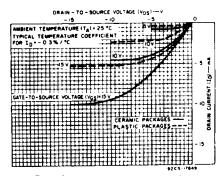


Fig. 10 — Minimum p-channel drain characteristics.

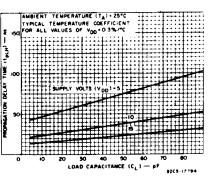


Fig. 11 — Typical low-to-high level propagation delay time vs. C_L .

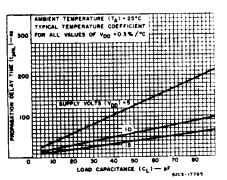


Fig. 12 -- Typical high-to-low level propagation delay time vs. C_L - CD4011A, & CD4023A.

CD4011A, CD4012A, CD4023A Types

DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C, C_L = 15 pF, input t_r , t_f = 20 ns, R_L = 200 K Ω

	TES	Т		UNITS					
CHARACTERISTICS	CONDIT	CONDITIONS			E Package				
		V _{DD} (V)	Тур.	Max.	Тур.	Max.			
Propagation Delay Time:		5	50	75	50	100	ns		
Low-to-High Level, tpLH		10	25	40	25	50] '''		
High-to-Low Level, tPHL CD4011A and CD4023A		5	50	75	50	100	ns		
		10	25	40	25	50			
CD4012A		5	100	150	100	200	ns		
		10	50	75	50	100			
Transition Time:		5	75	100	75	125	ns		
Low-to-High Level, t _{TLH}		10	40	60	40	75	1 "		
High-to-Low Level, t _{THL} CD4011A and CD4023A		5	75	125	75	150	ns		
		10	50	75	50	100			
CD4012A		5	250	375	250	500	ns		
		10	125	200	125	250			
Input Capacitance, C _I	Any In	put	5	_	5	_	рF		

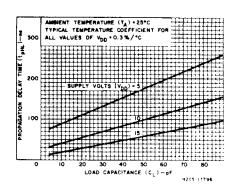


Fig. 13 — Typical high-to-low level propagation delay time vs. C_L — CD4012A.

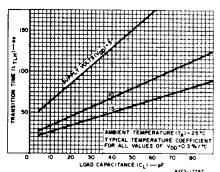


Fig. 14 — Typical low-to-high transition time vs. C_L .

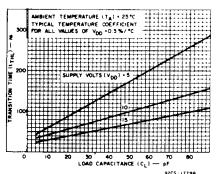


Fig. 15 — Typical high-to-low level transition time vs. C_L — CD4011A & CD4023A.

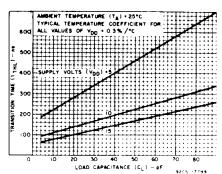


Fig. $16 - Typical high-to-low level transition time vs. <math>C_L - CD4012A$.

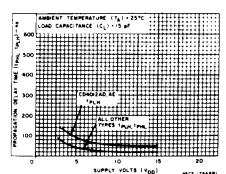


Fig. 17 — Minimum propagation delay time vs. VDD.

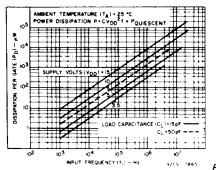


Fig. 18 - Typical dissipation characteristics.

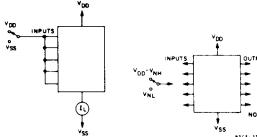


Fig. 19 — Quiescent device current test circuit.

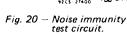


Fig. 21 - Input leakage current test circuit.

MEASURE INPUTS
SEQUENTIALLY,
TO BOTH VOD AND VSS
CONNECT ALL UNUSED
INPUTS TO EITHER

V_{DO} OR V_{SS}

PACKAGE OPTION ADDENDUM

www.ti.com 15-Oct-2009

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD4011AD3	ACTIVE	CDIP SB	JD	14	1	TBD	POST-PLATE	N / A for Pkg Type
CD4023AFB	OBSOLETE	CDIP	J	14		TBD	Call TI	Call TI
JM38510/05001BCA	ACTIVE	CDIP	J	14	1	TBD	A42	N / A for Pkg Type
JM38510/05003BCA	OBSOLETE	CDIP	J	14	•	TBD	Call TI	Call TI
M/05003BCA	OBSOLETE	CDIP	J	14		TBD	Call TI	Call TI

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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14 LEADS SHOWN

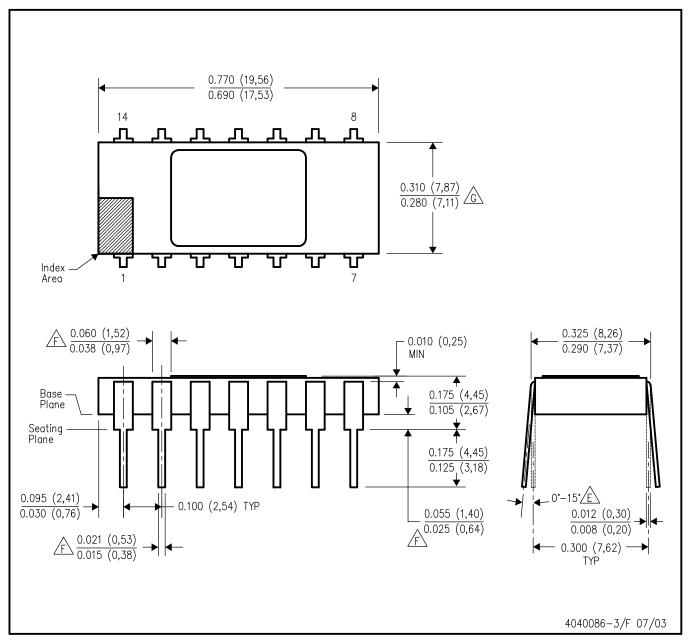


NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

JD (R-CDIP-T14)

CERAMIC SIDE-BRAZE DUAL-IN-LINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Controlling dimension: inch.
- D. Leads within 0.005 (0,13) radius of true position (TP) at gage plane with maximum material condition and unit installed.
- E Angle applies to spread leads prior to installation.
- F Outlines on which the seating plane is coincident with the plane (standoff = 0), terminals lead standoffs are not required, and lead shoulder may equal lead width along any part of the lead above the seating/base plane.
- G Body width does not include particles of packing materials.
- H. A visual index feature must be located within the cross—hatched area.



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